

Notice of References Cited	Application/Control No. 10/561,581		Applicant(s)/Patent Under Reexamination GAUDON ET AL.	
	Examiner NATHAN H. EMPIE		Art Unit 1792	Page 1 of 1

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*	B	US-2003/0003237	01-2003	Seabaugh et al.	427/421
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*	D	US-2004/0115416	06-2004	Nonninger et al.	428/304.4
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.